Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/735,446	YOON ET AL.	
Examiner	Art Unit	
Jared W. Newton	3634	

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Class	Subclass	Date	Examiner			
2 //	updated Search	06/21/06	TW			
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Primary Examiner Scarch: Korie Chan, class 248	00/20/06	Sens	
Painany Examiner Search: Lloyd Gall, Class 70	06/21/06	Shw	